FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.	SERIAL NO.
	LIST OF DOCUMENTS CITED BY APPLICANT *(Use several sheets if necessary)*	TI-36268	10/731,714
		APPLICANT: Agashe et al.	
		FILING DATE 12/09/2003	GROUP TBD

IPE JC24 JAN 12 2004 PATENT & TRADEMARK OFFICE

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
		US 6,587,981 B1	07/01/03	Muradali et al.	714	726	11/29/99
		US 6,442,722 B1	08/27/02	Nadeau-Dostie et al.	714	731	10/29/99
		US 6,598,192 B1	07/22/03	McLaurin et al.	714	726	02/28/00
		5,663,966	09/02/97	Day et al.	371	22.36	07/24/96
		6,106,568	08/22/00	Beausang et al.	716	18	06/03/99
		6,304,988 B1	10/16/01	Levy	714	726	03/17/00

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

		"Scan-Based Transition Fault Testing – Implementation and Low Cost Test Challenges" Saxena et al., ITC International Test Conference, IEEE 2002, pp 1120-1129

EXAMINER	DATE CONSIDERED
John P. Trissino	4/11/06

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.